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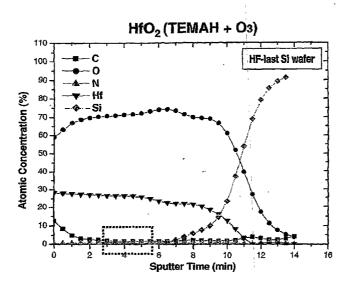
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[Continued on next page]

(54) Title: ATOMIC LAYER DEPOSITION OF HAFNIUM-BASED HIGH-K DIELECTRIC

AES Analysis of HfO2 Film obtained from TEMAHf / O3



(57) Abstract: A method of depositing a hafnium-based dielectric film is provided. The method comprises atomic layer deposition using ozone and one or more reactants comprising a hafnium precursor. A semiconductor device is also provided. The device comprises a substrate, a hafnium-based dielectric layer formed atop the substrate, and an interfacial layer formed between the substrate and the hafnium-based dielectric layer, wherein the interfacial layer comprises silicon dioxide and has a crystalline structure.

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US CL : 117/88				
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NONE				
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C. DOCT	UMENTS CONSIDERED TO BE RELEVANT			
Category *	Citation of document, with indication, where ap	Relevant to claim No.		
X, P	US 2004/0092073 A1 (CABRAL JR. et al) 13 May 2004		1, 2, 4-9, 11-15	
Y			10	
_Y	US 2002/0195643 A1 (HARADA) 26 December 2002 (26.12.2002) see entire document.		10	
A, P US 2003/0232511 A1 (METZNER et al) 18 Decemb		per 2003 (18.12.2003) see entire	1-15	
document.		,		
A	US 2002/0064970 A1 (CHOOI et al) 30 May 2002 (30.05.2002) see entire document.	1-15	
A GG 2002/0004570 III (GIIOOI et al) 50 May 2002 (50.00)		,		
A, P	US 6,787,481 B2 (ASAI et al) 07 September 2004 (07.09.2004) see entire document.	1-15	
A, 1	000,707,10100 (185110100) 07 00000000000000000000000000000			
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Further	documents are listed in the continuation of Box C.	See patent family annex.		
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Continuation of B. FIELDS SEARCHED Item 3: WEST; PGPB, USPT, USOC, EPAB, JPAB, DWPI, TDBD; (precursor same (oxygen or "o.sub.2")) and (hfo or (hafnium adj oxide)) and amorphous.				

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